

Notice of References Cited	Application/Control No. 10/774,607	Applicant(s)/Patent Under Reexamination NAKAI, SHINYA	
	Examiner Tuan A. Tran	Art Unit 2618	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,759,924	07-2004	Sakuragawa et al.	333/133
*	B	US-6,380,823	04-2002	Ikata et al.	333/133
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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